

SIOV metal oxide varistors

Housed (ThermoFuse) varistors, AdvanceD series

Series/Type: T14 series
Date: April 2018

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ThermoFuse varistors

Construction

- Round varistor element, leaded
- Coating: epoxy resin, flame-retardant to UL 94 V-0
- Terminals: tinned copper wire, metal compound wire
- Housing: thermoplastic, flame-retardant to UL 94 V-0

Features

- Wide operating voltage range 130 ... 420 V_{RMS}
- Self-protected under abnormal overvoltage conditions
- High-energy AdvanceD series E2

Approvals

- UL 1449 (file number E321126)
- IEC (certificate number 101-QA-10 IECQ)
- VDE (certificate number 40031102)

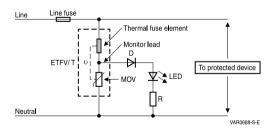
Applications

- Houshold appliances
- Power supply units
- Inverters in solar power systems
- Lighting applications
- Communication and data systems
- Transient voltage surge suppressors (TVSS)
- Electronic metering

Delivery mode

Typical applications

Tray packing



General technical data

Climatic category	to IEC 60068-1	40/85/56	
Operating temperature	to IEC 61051	-40 + 85	°C
Storage temperature		-40 + 85	°C
Electric strength	to IEC 61051	≥ 2.5	kV _{RMS}
Insulation resistance	to IEC 61051	≥ 100	ΜΩ



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Electrical specifications and ordering codes Maximum ratings (T_A = 85 °C)

Ordering code	Туре	V_{RMS}	V_{DC}	i _{max}	I _n 1)	W_{max}	P _{max}
· ·	(untaped)			(8/20 µs)	(8/20 µs)	(2 ms)	
					15 times		
	SIOV-	٧	V	Α	Α	J	W
B72214T2131K105	T14K130E2	130	170	6000	3000	50	0.6
B72214T2151K105	T14K150E2	150	200	6000	3000	60	0.6
B72214T2171K105	T14K175E2	175	225	6000	3000	70	0.6
B72214T2231K105	T14K230E2	230	300	6000	3000	90	0.6
B72214T2251K105	T14K250E2	250	320	6000	3000	100	0.6
B72214T2271K105	T14K275E2	275	350	6000	3000	110	0.6
B72214T2301K105	T14K300E2	300	385	6000	3000	125	0.6
B72214T2321K105	T14K320E2	320	420	6000	3000	136	0.6
B72214T2351K105	T14K350E2	350	460	6000	3000	150	0.6
B72214T2381K105	T14K385E2	385	505	6000	3000	165	0.6
B72214T2421K105	T14K420E2	420	560	6000	3000	180	0.6

¹⁾ **Note:** Nominal discharge current I_n according to UL 1449, 4th edition.

Characteristics (T_A = 25 °C)

Ordering code	Туре	V _v	ΔV_{v}	V _{c,max}	i _c	C _{typ}
	(untaped)	(1 mA)	(1 mA)	(i _c)		(1 kHz)
	SIOV-	V	%	V	Α	pF
B72214T2131K105	T14K130E2	205	±10	340	50	880
B72214T2151K105	T14K150E2	240	±10	395	50	750
B72214T2171K105	T14K175E2	270	±10	455	50	670
B72214T2231K105	T14K230E2	360	±10	595	50	530
B72214T2251K105	T14K250E2	390	±10	650	50	490
B72214T2271K105	T14K275E2	430	±10	710	50	440
B72214T2301K105	T14K300E2	470	±10	775	50	400
B72214T2321K105	T14K320E2	510	±10	840	50	370
B72214T2351K105	T14K350E2	560	±10	910	50	340
B72214T2381K105	T14K385E2	620	±10	1025	50	315
B72214T2421K105	T14K420E2	680	±10	1120	50	290





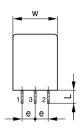
Housed varistors

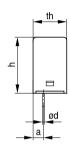
T14 series

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Dimensional drawings in mm







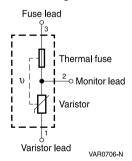


VAR0705-M

Weight

Nominal diameter	V _{RMS}	Weight
mm	V	g
14	130 420	4.1 6.1

Lead configuration





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Reliability data

Test	Test methods/ conditions	Requirement
Varistor voltage	The voltage between two terminals with the specified measuring current applied is called V_{V} (1 mA _{DC} @ 0.2 2 s).	To meet the specified value
Clamping voltage	The maximum voltage between two terminals with the specified standard impulse current (8/20 µs) applied.	To meet the specified value
Endurance at upper category temperature	1000 h at UCT After having continuously applied the maximum allowable AC voltage at UCT ± 2 °C for 1000 h, the specimen shall be stored at room temperature and normal humidity for 1 to 2 h. Thereafter, the change of V $_{\rm V}$ shall be measured.	IΔV/V (1 mA)I ≤10%
Surge current derating, 8/20 μs	10 surge currents (8/20 μ s), unipolar, interval 30 s, amplitude corresponding to derating curve for 10 impulses at 20 μ s	∆V/V (1 mA) ≤10% (measured in direction of surge current) No visible damage
Surge current derating, 2 ms	10 surge currents (2 ms), unipolar, interval 120 s, amplitude corresponding to derating curve for 10 impulses at 2 ms	IΔV/V (1 mA)I ≤10% (measured in direction of surge current) No visible damage
Electric strength	IEC 61051-1, test 4.9.2 Metal balls method, 2500 V _{RMS} , 60 s The varistor is placed in a container holding 1.6 ±0.2 mm diameter metal balls such that only the terminations of the varistor are protruding. The specified voltage shall be applied between both terminals of the specimen connected together and the electrode inserted between the metal balls.	No breakdown





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Test	Test methods/ conditions	Requirement
Climatic sequence	The specimen shall be subjected to: a) dry heat at UCT, 16 h, IEC 60068-2-2, test Ba b) damp heat, 1st cycle: 55 °C, 93% r. H., 24 h, IEC 60068-2-30, test Db. c) cold, LCT, 2 h, IEC 60068-2-1, test Aa. d) damp heat, additional 5 cycles: 55 °C/25 °C, 93% r. H., 24 h/cycle, IEC 60068-2-30, test Db.	$ \Delta V/V $ (1 mA) ≤10% $R_{ins} ≥100 MΩ$
	Then the specimen shall be stored at room temperature and normal humidity for 1 to 2 h. Thereafter, the change of V_V shall be measured. Thereafter, insulation resistance R_{ins} shall be measured at $V = 500 \text{ V}$.	
Rapid change of temperature	IEC 60068-2-14, test Na, LCT/UCT, dwell time 30 min, 5 cycles	l∆V/V (1 mA)l ≤5% No visible damage
Damp heat, steady state	IEC 60068-2-78, test Ca The specimen shall be subjected to 40 ± 2 °C, 90 to 95% r. H. for 56 days without load / with 10% of the maximum continuous DC operating voltage V _{DC} . Then stored at room temperature and normal humidity for 1 to 2 h. Thereafter, the change of V _V shall be measured. Thereafter, insulation resistance R _{ins} shall be measured at V = 500 V (insulated varistors only).	$I\Delta V/V$ (1 mA)I ≤10% R_{ins} ≥100 MΩ



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Test	Test methods/ conditions	Requirement
Solderability	IEC 60068-2-20, test Ta, method 1 with modified conditions for lead-free solder alloys: 245 °C, 3 s: After dipping the terminals to a depth of approximately 3 mm from the body in a soldering bath of 245 °C for 3 s, the terminals shall be visually examined.	The inspection must be carried out under adequate light with normal eyesight or with the assistance of a magnifier capable of giving a magnification of 4 to 10 times. The dipped surface must be covered with a smooth and bright solder coating with no more than small amounts of scattered imperfections such as pinholes or un-wetted or de-wetted areas. These imperfections must not be concentrated in one area.
Resistance to soldering heat	IEC 60068-2-20, test Tb, method 1A, 260 °C, 10 s: Each lead shall be dipped into a solder bath having a temperature of 260 ± 5 °C to a point 2.0 to 2.5 mm from the body of the specimen, be held there for 10 ± 1 s and then be stored at room temperature and normal humidity for 1 to 2 h. The change of V_V shall be measured and the specimen shall be visually examined.	I∆V/V (1 mA)I ≤5% No visible damage
Tensile strength	IEC 60068-2-21, test Ua1 After gradually applying the force specified below and keeping the unit fixed for 10 s, the terminal shall be visually examined for any damage. Force for wire diameter: 0.6 mm = 10 N 0.8 mm = 10 N 1.0 mm = 20 N	I∆V/V (1 mA)I ≤5% No break of solder joint, no wire break





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device for different types as in the following table: Type Device rating voltage V _{RMS} V _{RMS} V _{RMS} V _{RMS} V _{RMS} V _{RMS} T14K130E2 130 260 T14K150E2 150 300 T14K230E2 175 350 T14K230E2 230 415 T14K275E2 275 480 T14K300E2 300 600 T14K300E2 300 600 T14K30E2 350 600 T14K350E2 350 600 T14K385E2 385 600 metal, glowing or flaming particles through any openings (pre-existing or created as a result of the test) in the product. Charring, glowing, or flaming particles through any openings (pre-existing or created as a result of the test) in the product. Charring, glowing or flaming particles through any openings (pre-existing or created as a result of the test) in the product. Charring, glowing or flaming particles through any openings (pre-existing or created as a result of the test) in the product. Charring, glowing, or flaming particles through any openings (pre-existing or created as a result of the test) in the product. Charring, glowing or flaming particles through any openings (pre-existing or created as a result of the test) in the product. Charring, glowing or flaming particles through any openings (pre-existing or created as a result of the test) in the product. Charring, glowing or flaming particles through any openings (pre-existing or created as a result of the test) in the product. Charring, glowing or flaming particles through any openings (pre-existing or created as a result of the test) in the product. Charring, glowing, or flaming particles through any openings (pre-existing or created as a result of the test) in the product. Charring as a result of the test) in the product. Charring as a result of the test) in the product. Charring as a result of the test) in the product. Charring as a result of the test) in the product. Charring as a result of the test) in the product. Charring as a result of the test) in the product. Charring as a result of the test) in the product. Charring as a result of the test) in the product. Charring as a result of the	Test	Test methods/ co	nditions		Re	quirement	
Frequency range: 10 55 Hz Amplitude: 0.75 mm or 98 m/s² Duration: 6 h (3 · 2 h) Pulse: sine wave After repeatedly applying a single harmonic vibration according to the table above. The change of V _V shall be measured and the specimen shall be visually examined. Bump IEC 60068-2-29, test Eb Pulse duration: 6 ms Max. acceleration: 400 m/s² Number of bumps: 4000 Pulse: half sine Fire hazard IEC 60695-11-5 (needle flame test) Severity: vertical 10 s Abnormal overvoltage test Imited current abnormal overvoltage condition, outlined in section 39.4 of UL 1449, 4 th edition. Detailed test voltage applied onto the device for different types as in the following table: Type Device rating voltage V _{RMS} V _{RMS} V _{RMS} T14K130E2 130 260 T14K150E2 150 300 T14K150E2 250 500 T14K275E2 275 480 T14K300E2 300 600 T14K300E2 320 600 T14K330E2 350 600 T14K385E2 385 600 No visible damage No visible damage IΔV/V (1 mA)I ≤5% No visible damage	Vibration	IEC 60068-2-6, te	st Fc, met	hod B4	IΔV	//V (1 mA)l ≤5%	
Amplitude: 0.75 mm or 98 m/s² Duration: 6 h (3 · 2 h) Pulse: sine wave After repeatedly applying a single harmonic vibration according to the table above. The change of V _v shall be measured and the specimen shall be visually examined. Bump IEC 60068-2-29, test Eb Pulse duration: 6 ms Max. acceleration: 400 m/s² Number of bumps: 4000 Pulse: half sine Fire hazard IEC 60695-11-5 (needle flame test) Severity: vertical 10 s Abnormal Overvoltage test limited current abnormal overvoltage condition, outlined in section 39.4 of UL 1449, 4th edition. Detailed test voltage applied onto the device for different types as in the following table: Type Device Test rating voltage V _{RMS} V _{RMS} T14K130E2 130 260 T14K130E2 150 300 T14K250E2 250 500 T14K225E2 275 480 T14K300E2 300 600 T14K330E2 320 600 T14K330E2 350 600 T14K330E2 350 600 T14K385E2 385 600		Frequency range: 10 55 Hz					
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Number of bumps: 4000 Pulse: half sine					No	visible damage	
Fire hazard Fire hazard IEC 60695-11-5 (needle flame test) Severity: vertical 10 s Abnormal overvoltage test The device is designed to meet the limited current abnormal overvoltage condition, outlined in section 39.4 of UL 1449, 4th edition. Detailed test voltage applied onto the device for different types as in the following table: Type Device Test rating voltage VRMS VRMS VRMS T14K130E2 130 260 T14K150E2 150 300 T14K175E2 175 350 T14K230E2 230 415 T14K250E2 250 500 T14K275E2 275 480 T14K300E2 300 600 T14K320E2 320 600 T14K320E2 320 600 T14K350E2 350 600 T14K350E2 385 600 T14K385E2 385 600							
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parts test in section 58.2		T14K420E2	420	600		•	
of UL1449, 4th edition.						•	

Note:

 $UCT = Upper category temperature, LCT = Lower category temperature, R_{ins} = Insulation resistance. All electrical tests should be performed between pin 1 and pin 3.$

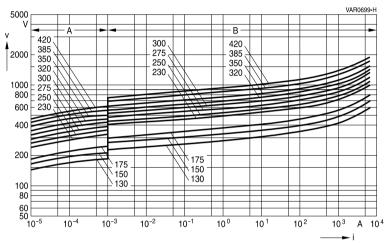


ThermoFuse varistors



v/i characteristics

v = f (i) for explanation of the characteristics refer to "General technical information", chapter 1.6.3 A = Leakage current, B = Protection level } for worst-case varistor tolerances

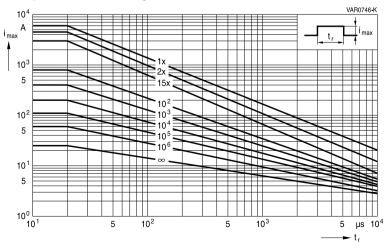


SIOV-T14 ... E2

Derating curves

Maximum surge current $i_{max} = f(t_r, pulse train)$

For explanation of the derating curves refer to "General technical information", section 1.8.1



SIOV-T14 ... E2





Cautions and warnings

General

- EPCOS metal oxide varistors are designed for specific applications and should not be used for purposes not identified in our specifications, application notes and data books unless otherwise agreed with EPCOS during the design-in-phase.
- Ensure suitability of SIOVs through reliability testing during the design-in phase. SIOVs should be evaluated taking into consideration worst-case conditions.
- 3. For applications of SIOVs in line-to-ground circuits based on various international and local standards there are restrictions existing or additional safety measures required.

Storage

- 1. Store SIOVs only in original packaging. Do not open the package prior to processing.
- 2. Recommended storage conditions in original packaging:

Storage temperature: $-25 \,^{\circ}\text{C} \dots +45 \,^{\circ}\text{C}$,

Relative humidity: <75% annual average,

<95% on maximum 30 days a year.

Dew precipitation: is to be avoided.

- 3. Avoid contamination of an SIOV's during storage, handling and processing.
- Avoid storage of SIOVs in harmful environments that can affect the function during long-term operation (examples given under operation precautions).
- The SIOV type series should be soldered after shipment from EPCOS within the time specified:

SIOV-S, -Q, -LS, -B, -SNF 24 months ETFV/ T series. -CU 12 months.

Handling

- 1. SIOVs must not be dropped.
- 2. Components must not be touched with bare hands. Gloves are recommended.
- Avoid contamination of the surface of SIOV electrodes during handling, be careful of the sharp edge of SIOV electrodes.

Soldering (where applicable)

- 1. Use rosin-type flux or non-activated flux.
- Insufficient preheating may cause ceramic cracks.
- 3. Rapid cooling by dipping in solvent is not recommended.
- 4. Complete removal of flux is recommended.
- Temperatures of all preheat stages and the solder bath must be strictly controlled especially for T series (T14 and T20).



Housed varistors	T14 series	
ThermoFuse varistors		



Mounting

- 1. Potting, sealing or adhesive compounds can produce chemical reactions in the SIOV ceramic that will degrade the component's electrical characteristics.
- 2. Overloading SIOVs may result in ruptured packages and expulsion of hot materials. For this reason SIOVs should be physically shielded from adjacent components.

Operation

- 1. Use SIOVs only within the specified temperature operating range.
- 2. Use SIOVs only within the specified voltage and current ranges.
- Environmental conditions must not harm SIOVs. Use SIOVs only in normal atmospheric conditions. Avoid use in deoxidizing gases (chlorine gas, hydrogen sulfide gas, ammonia gas, sulfuric acid gas etc), corrosive agents, humid or salty conditions. Contact with any liquids and solvents should be prevented.

Display of ordering codes for EPCOS products

The ordering code for one and the same EPCOS product can be represented differently in data sheets, data books, other publications, on the EPCOS website, or in order-related documents such as shipping notes, order confirmations and product labels. The varying representations of the ordering codes are due to different processes employed and do not affect the specifications of the respective products. Detailed information can be found on the Internet under www.epcos.com/orderingcodes





ThermoFuse varistors

Symbols and terms

·,	
Symbol	Term
С	Capacitance
C_{typ}	Typical capacitance
i	Current
i _c	Current at which V _{c, max} is measured
I _{leak}	Leakage current
i _{max}	Maximum surge current (also termed peak current)
I _{max}	Maximum discharge current
I _n	Nominal discharge current to UL 1449
LCT	Lower category temperature
L_{typ}	Typical inductance
P_{max}	Maximum average power dissipation
R _{ins}	Insulation resistance
R_{min}	Minimum resistance
T_A	Ambient temperature
t _r	Duration of equivalent rectangular wave
UCT	Upper category temperature
V	Voltage
V_{clamp}	Clamping voltage
V _{c, max}	Maximum clamping voltage at specified current i _c
V_{DC}	DC operating voltage
V_{jump}	Maximum jump start voltage
V_{max}	Maximum voltage
V_{op}	Operating voltage
V_{RMS}	AC operating voltage, root-mean-square value
$V_{RMS,\;op,\;max}$	Root-mean-square value of max. DC operating voltage incl. ripple current
V_{surge}	Super imposed surge voltage
V_{V}	Varistor voltage
ΔV_{V}	Tolerance of varistor voltage
W_{LD}	Maximum load dump
W_{max}	Maximum energy absorption
е	Lead spacing

All dimensions are given in mm.

The commas used in numerical values denote decimal points.



Important notes

The following applies to all products named in this publication:

- 1. Some parts of this publication contain statements about the suitability of our products for certain areas of application. These statements are based on our knowledge of typical requirements that are often placed on our products in the areas of application concerned. We nevertheless expressly point out that such statements cannot be regarded as binding statements about the suitability of our products for a particular customer application. As a rule we are either unfamiliar with individual customer applications or less familiar with them than the customers themselves. For these reasons, it is always ultimately incumbent on the customer to check and decide whether a product with the properties described in the product specification is suitable for use in a particular customer application.
- 2. We also point out that in individual cases, a malfunction of electronic components or failure before the end of their usual service life cannot be completely ruled out in the current state of the art, even if they are operated as specified. In customer applications requiring a very high level of operational safety and especially in customer applications in which the malfunction or failure of an electronic component could endanger human life or health (e.g. in accident prevention or life-saving systems), it must therefore be ensured by means of suitable design of the customer application or other action taken by the customer (e.g. installation of protective circuitry or redundancy) that no injury or damage is sustained by third parties in the event of malfunction or failure of an electronic component.
- 3. The warnings, cautions and product-specific notes must be observed.
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Important notes

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